	Application No.	Applicant(s)
Notice of Allowability	10/804,926	KHAZENI ET AL.
	Examiner	Art Unit
	Marissa J. Detschel	2877
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. X This communication is responsive to <u>Amendment filed October 19, 2006</u> .		
2. The allowed claim(s) is/are <u>1-16 and 18-20</u> .		
<ul> <li>3. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some* c) None of the: <ol> <li>Certified copies of the priority documents have been received.</li> <li>Certified copies of the priority documents have been received in Application No.</li> <li>Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).</li> </ol> </li> <li>* Certified copies not received:</li> </ul>		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.  THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.		
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.		
(a) 🔲 including changes required by the Notice of Draftsperson's Patent Drawing Review ( PTO-948) attached		
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date		
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).		
6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s)		
1. Notice of References Cited (PTO-892)	5. Notice of Informal Pa	atent Application
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Summary	(PTO-413),
3. Information Disclosure Statements (PTO/SB/08), Paper No./Mail Date 8/13/04	Paper No./Mail Date 7. ☐ Examiner's Amendr	e nent/Comment
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. ⊠ Examiner's Stateme 9. □ Other	nt of Reasons for Allowance
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## Allowable Subject Matter

Claims 1-16 and 18-20 are allowed in view of the prior art.

The following is an examiner's statement of reasons for allowance:

As to claims 1, 9, and 18, the prior art of record, taken alone or in combination, fails to disclose or render obvious the used of an elliptical cavity positioned adjacent to the point of impingement by a beam onto a substrate to capture the scattered light from the substrate and detect information incorporated into the scattered light in an optical measuring system for evaluating a substrate, in combination with the rest of the limitations of claims 1, 9, and 18.

As to claim 11, the prior art of record, taken alone or in combination, fails to disclose or render obvious an elliptical cavity assembly comprising a truncated elliptical cavity that is positioned with a surface under examination in combination with a quarter wave plate that can be tilted with respect to the beam axis for detection of surface scattered light in a reflectance surface analyzer, in combination with the rest of the limitations of claim 11.

As to claims 12, 13, and 19, the prior art of record, taken alone or in combination, fails to disclose or render obvious an optical measuring system for evaluating a substrate comprising a quarter wave plate that can be tilted with respect to an axis of an input beam, in combination with the rest of the limitations of claims 12, 13, and 19.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably Art Unit: 2877

accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Information Disclosure Statement

The information disclosure statement filed on August 13, 2004, contains a document (Cite No. X, Optics, Miles V. Klein and Thomas E. Furtak, Second Edition, Wiley, pp. 134-135) without a subsequent date. Also, no copies of the McGrawHill, Inc. reference or the Wafers and Flat Panels Display reference were included with the information disclosure statement filed on the same date. In view of this, these documents were not considered by the Examiner.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Marissa J. Detschel whose telephone number is 571-272-2716. The examiner can normally be reached on M-F 8:30am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Gregory J. Toatley, Jr. can be reached on 571-272-2059. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

MJD October 20, 2006

Gradin J. Toatley Jr.
Supervisory Patent Examiner